

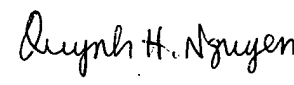


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/098,508	WEIK ET AL.	
	Examiner	Art Unit	
	Quynh H. Nguyen	2614	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
379		203.01		379	111	214.01	218.02	265.01	
INTERNATIONAL CLASSIFICATION				705	35				
H	0	4	M						
				3/42					
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 (Assistant Examiner) (Date)		 QUYNH H. NGUYEN PRIMARY EXAMINER (Primary Examiner) (Date)		Total Claims Allowed: 18 O.G. Print Claim(s) 1 O.G. Print Fig. 1	
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<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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